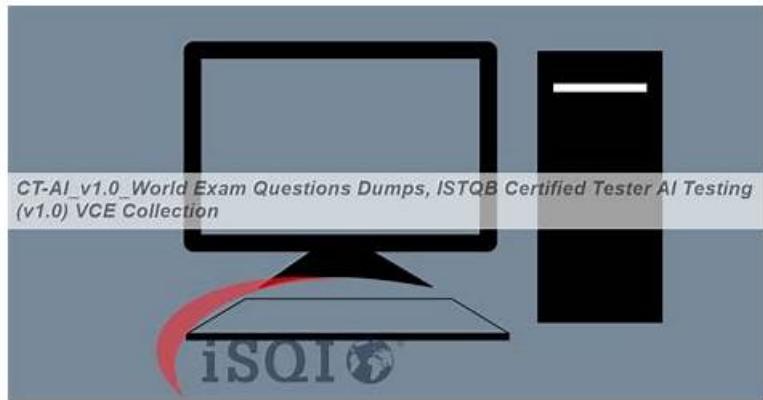


# CT-AI Free Sample Questions, Real CT-AI Dumps Free



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As for the CT-AI study materials themselves, they boast multiple functions to assist the learners to learn the study materials efficiently from different angles. For example, the function to stimulate the exam can help the exam candidates be familiar with the atmosphere and the pace of the Real CT-AI Exam and avoid some unexpected problem occur. Briefly speaking, our CT-AI training guide gives priority to the quality and service and will bring the clients the brand new experiences and comfortable feelings to pass the CT-AI exam.

## ISTQB CT-AI Exam Syllabus Topics:

Topic	Details
Topic 1	<ul style="list-style-type: none"><li>Test Environments for AI-Based Systems: This section is about factors that differentiate the test environments for AI-based</li></ul>
Topic 2	<ul style="list-style-type: none"><li>Quality Characteristics for AI-Based Systems: This section covers topics covered how to explain the importance of flexibility and adaptability as characteristics of AI-based systems and describes the vitality of managing evolution for AI-based systems. It also covers how to recall the characteristics that make it difficult to use AI-based systems in safety-related applications.</li></ul>
Topic 3	<ul style="list-style-type: none"><li>Introduction to AI: This exam section covers topics such as the AI effect and how it influences the definition of AI. It covers how to distinguish between narrow AI, general AI, and super AI; moreover, the topics covered include describing how standards apply to AI-based systems.</li></ul>
Topic 4	<ul style="list-style-type: none"><li>Using AI for Testing: In this section, the exam topics cover categorizing the AI technologies used in software testing.</li></ul>
Topic 5	<ul style="list-style-type: none"><li>systems from those required for conventional systems.</li></ul>
Topic 6	<ul style="list-style-type: none"><li>Methods and Techniques for the Testing of AI-Based Systems: In this section, the focus is on explaining how the testing of ML systems can help prevent adversarial attacks and data poisoning.</li></ul>
Topic 7	<ul style="list-style-type: none"><li>ML: Data: This section of the exam covers explaining the activities and challenges related to data preparation. It also covers how to test datasets create an ML model and recognize how poor data quality can cause problems with the resultant ML model.</li></ul>

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## 2026 ISTQB Useful CT-AI: Certified Tester AI Testing Exam Free Sample Questions

As you know the registration fee for the Certified Tester AI Testing Exam (CT-AI) certification exam is itself very high, varying between 100\$ and 1000\$. And after paying the registration fee for better preparation a candidate needs budget-friendly and reliable Certified Tester AI Testing Exam (CT-AI) pdf questions. That is why TroytecDumps has compiled the most reliable updated ISTQB CT-AI Exam Questions with up to 1 year of free updates. The ISTQB CT-AI practice test can be used right after being bought by the customer and they can avail of the benefits given in the Certified Tester AI Testing Exam (CT-AI) pdf questions.

## ISTQB Certified Tester AI Testing Exam Sample Questions (Q77-Q82):

### NEW QUESTION # 77

Before deployment of an AI-based system, a developer is expected to demonstrate in a test environment how decisions are made. Which of the following characteristics does decision making fall under?

- A. Autonomy
- B. Self-learning
- C. Non-determinism
- D. **Explainability**

**Answer: D**

Explanation:

The syllabus defines explainability as the ability to understand how the AI-based system comes up with a particular result: "Explainability is considered to be the ease with which users can determine how the AI-based system comes up with a particular result." (Reference: ISTQB CT-AI Syllabus v1.0, Section 2.7)

### NEW QUESTION # 78

Which ONE of the following tests is MOST likely to describe a useful test to help detect different kinds of biases in ML pipeline?  
SELECT ONE OPTION

- A. Testing the distribution shift in the training data for inappropriate bias.
- B. Testing the data pipeline for any sources for algorithmic bias.
- C. **Test the model during model evaluation for data bias.**
- D. Check the input test data for potential sample bias.

**Answer: C**

Explanation:

Detecting biases in the ML pipeline involves various tests to ensure fairness and accuracy throughout the ML process.

\* Testing the distribution shift in the training data for inappropriate bias (A): This involves checking if there is any shift in the data distribution that could lead to bias in the model. It is an important test but not the most direct method for detecting biases.

\* Test the model during model evaluation for data bias (B): This is a critical stage where the model is evaluated to detect any biases in the data it was trained on. It directly addresses potential data biases in the model.

\* Testing the data pipeline for any sources for algorithmic bias (C): This test is crucial as it helps identify biases that may originate from the data processing and transformation stages within the pipeline. Detecting sources of algorithmic bias ensures that the model does not inherit biases from these processes.

\* Check the input test data for potential sample bias (D): While this is an important step, it focuses more on the input data and less on the overall data pipeline.

Hence, the most likely useful test to help detect different kinds of biases in the ML pipeline is B. Test the model during model evaluation for data bias.

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ISTQB CT-AI Syllabus Section 8.3 on Testing for Algorithmic, Sample, and Inappropriate Bias discusses various tests that can be performed to detect biases at different stages of the ML pipeline.

Sample Exam Questions document, Question #32 highlights the importance of evaluating the model for biases.

### NEW QUESTION # 79

Pairwise testing can be used in the context of self-driving cars for controlling an explosion in the number of combinations of parameters.

Which ONE of the following options is LEAST likely to be a reason for this incredible growth of parameters?

SELECT ONE OPTION

- A. Different weather conditions
- B. Different Road Types
- C. Different features like ADAS, Lane Change Assistance etc.
- D. **ML model metrics to evaluate the functional performance**

**Answer: D**

Explanation:

Pairwise testing is used to handle the large number of combinations of parameters that can arise in complex systems like self-driving cars. The question asks which of the given options is least likely to be a reason for the explosion in the number of parameters.

\* Different Road Types (A): Self-driving cars must operate on various road types, such as highways, city streets, rural roads, etc. Each road type can have different characteristics, requiring the car's system to adapt and handle different scenarios. Thus, this is a significant factor contributing to the growth of parameters.

\* Different Weather Conditions (B): Weather conditions such as rain, snow, fog, and bright sunlight significantly affect the performance of self-driving cars. The car's sensors and algorithms must adapt to these varying conditions, which adds to the number of parameters that need to be considered.

\* ML Model Metrics to Evaluate Functional Performance (C): While evaluating machine learning (ML) model performance is crucial, it does not directly contribute to the explosion of parameter combinations in the same way that road types, weather conditions, and car features do. Metrics are used to measure and assess performance but are not themselves variable conditions that the system must handle.

\* Different Features like ADAS, Lane Change Assistance, etc. (D): Advanced Driver Assistance Systems (ADAS) and other features add complexity to self-driving cars. Each feature can have multiple settings and operational modes, contributing to the overall number of parameters.

Hence, the least likely reason for the incredible growth in the number of parameters is C. ML model metrics to evaluate the functional performance.

References:

\* ISTQB CT-AI Syllabus Section 9.2 on Pairwise Testing discusses the application of this technique to manage the combinations of different variables in AI-based systems, including those used in self-driving cars.

\* Sample Exam Questions document, Question #29 provides context for the explosion in parameter combinations in self-driving cars and highlights the use of pairwise testing as a method to manage this complexity.

**NEW QUESTION # 80**

Which of the following is a problem with AI-generated test cases that are generated from the requirements?

- A. They make debugging more complicated because the number of steps is usually high in order to induce the target failure
- B. They are slow and will usually not be able to execute in the time allowed
- C. **They are usually missing the expected results, so verification is difficult or must resort to only detecting significant failures**
- D. They are defect-prone because they are unable to detect nuances in the requirements

**Answer: C**

Explanation:

The syllabus mentions a drawback of AI-generated test cases:

"AI-based test generation tools can generate test cases... However, unless a test model that defines required behaviors is used as the basis of the tests, this form of test generation generally suffers from a test oracle problem because the AI-based tool does not know what the expected results should be." (Reference: ISTQB CT-AI Syllabus v1.0, Section 11.3, page 78 of 99)

**NEW QUESTION # 81**

Data used for an object detection ML system was found to have been labelled incorrectly in many cases.

Which ONE of the following options is most likely the reason for this problem?

SELECT ONE OPTION

- A. Accuracy issues
- B. Security issues
- C. Bias issues
- D. Privacy issues

**Answer: A**

### Explanation:

The question refers to a problem where data used for an object detection ML system was labelled incorrectly.

This issue is most closely related to "accuracy issues." Here's a detailed explanation:

\* Accuracy Issues: The primary goal of labeling data in machine learning is to ensure that the model can accurately learn and make predictions based on the given labels. Incorrectly labeled data directly impacts the model's accuracy, leading to poor performance because the model learns incorrect patterns.

### \* Why Not Other Options:

\* Security Issues: This pertains to data breaches or unauthorized access, which is not relevant to the problem of incorrect data labeling.

\* Privacy Issues: This concerns the protection of personal data and is not related to the accuracy of data labeling.

\* Bias Issues: While bias in data can affect model performance, it specifically refers to systematic errors or prejudices in the data rather than outright incorrect labeling.

References: This explanation is consistent with the concepts covered in the ISTQB CT-AI syllabus under dataset quality issues and their impact on machine learning models.

## NEW QUESTION # 82

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